

Public Hearing on Genetic Diagnostic Testing

University of San Diego 5998 Alcalá Park San Diego, CA 92110-2492

Friday, March 9, 2012 9:00 a.m.

Agenda

WebEx Information

Event number: 996 692 518 Event password: 123456

Event address for attendees: https://uspto-events.webex.com/uspto-events/onstage/g.php?d=996692518&t=a

Teleconference information

Call-in toll number (US/Canada): +1(408) 600 - 3600

Access code: 996 692 518

United States Patent and Trademark Office Panel

Teresa Stanek Rea, Deputy Under Secretary of Commerce for Intellectual Property and Deputy Director of the United States Patent and Trademark Office

Janet Gongola, Patent Reform Coordinator

Stuart Graham, Chief Economist

George Elliott, Technology Center Director (Biotechnology)

9:00 AM: Introduction

Janet Gongola, Patent Reform Coordinator

9:05 AM: Welcoming Remarks

Teresa Stanek Rea, Deputy Under Secretary of Commerce for Intellectual Property and Deputy Director of the United States Patent and Trademark Office

9:15 AM: Opening Commentary (Video)

Congresswoman Debbie Wasserman Schultz, U.S. House of Representatives

9:25 AM: Overview of Genetic Diagnostic Testing Study

Stuart Graham, Chief Economist

9:35 AM: Scheduled Testimony

9:35 – 9:55 AM	Richard Marsh, Executive Vice President, General Counsel and Secretary, Myriad Genetics
9:55 – 10:20 AM	Christopher Holman, Associate Professor of Law, University of Missouri-Kansas City School of Law
10:20 – 10:40 AM	Carlos Candeloro, Patent Attorney (Biotechnology)
10:40 – 10:55 AM	Break
10:55 – 11:15 AM	Bernard Greenspan, Director, Intellectual Property, Prometheus Laboratories

10:15 – 11:35AM **Misha Angrist,** Assistant Professor of the Practice, Duke Institute for Genomic Sciences &

Policy

11:35 – 11:55AM **Vern Norviel,** Partner, Wilson Sonsini Goodrich & Rosati

11:55 – 12:15AM Kimberly Irish, Program Manager, Breast Cancer Action

12:15 PM: Break for Lunch

1:45 PM: Open Floor for Unscheduled Testimony

Closing Remarks

Janet Gongola, Patent Reform Coordinator